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(FILE 'HOME' ENTERED AT 13:03:58 ON 22 NOV 1999)

FILE 'HCA' ENTERED AT 13:04:05 ON 22 NOV 1999

L1	724	SOLDER? AND INTERMETALLIC?
L2	504	L1 AND (TIN OR SN)
L3	104	L2 AND (COPPER OR CU) AND (SILVER OR AG)
L4	33	L2 AND COMPOSITE?
L5	20	L4 NOT L3
		E BIELER THOMAS/IN
		E BIELER THOMAS/AU
L6	206	E2-E5
		E BRIGHTON SUBRAMANIAN/AU
		E BRIGHTON SUBRAMANIAN/IN
		E CHOI SUNGLAK/IN
		E CHOI SUNGLAK/AU
		E CHOI SUNG/IN
L7	4	L6 AND L1

AN 129:345955 HCA  
TI Nanoindentation characterization of microphases in Sn-3.5Ag eutectic  
**solder** joints  
AU Lucas, J. P.; Gibson, A. W.; Subramanian, K. N.; **Bieler, T. R.**  
CS Michigan State University, East Lansing, MI, 48823, USA  
SO Mater. Res. Soc. Symp. Proc. (1998), 522 (Fundamentals of Nanoindentation  
and Nanotribology), 339-345  
CODEN: MRSPDH; ISSN: 0272-9172  
PB Materials Research Society  
DT Journal  
LA English  
AB Nanoindentation testing was used to obtain mech. properties on realistic  
Sn-Ag **solder** joints made with (1) eutectic Sn-3.5Ag  
**solder** (2) in-situ Cu<sub>6</sub>Sn<sub>5</sub> particle reinforced eutectic Sn-Ag  
matrix composite **solder**. The composite **solder** joint  
contained .apprx.20 vol.% added Cu<sub>6</sub>Sn<sub>5</sub> **intermetallic** particles  
.apprx.5 .mu. diam. The particles were dispersed in-situ in the eutectic  
Sn-3.5Ag matrix alloy as a reinforcement phase to stabilize the  
microstructure by acting as a non-coarsening microconstituent phase.  
Mech. property characterization and deformation behavior were assessed  
for  
the bulk microstructure and on microconstituents in the actual  
**solder** joints. Mech. property data obtained on constituents  
included hardness, elastic modulus, strain rate, and creep behavior. The  
pushing and rotation of the reinforcement particles that often occurred  
when contacted by the indenter provided a means for evaluating the  
interfacial shear strength of reinforcement particles in the  
**solder** matrix.

AN 131:302123 HCA  
TI The growth prevention of **intermetallic** compounds at the joint interface in lead-free **solder**  
AU Kayatani, Takayuki; Takaoka, Hidekiyo; Hamada, Kunihiro; Tokuda, Yu; Sakabe, Yukio  
CS R&D Division, Group II, Materials Development Department, MURATA, MFG CO;Ltd, oshinohara, yasuno-cho, shiga, 520-2393, Japan  
SO Symp. "Microjoining Assem. Technol. Electron." (1999), 5th, 433-438  
CODEN: SMAEFT  
PB Yosetsu Gakkai  
DT Journal  
LA Japanese  
AB The growth of **intermetallics** at the **solder**/substrate interface and electrode leaching are the main factors affecting the reliability of the **solder** joints for electronic components. We investigated the growth of **intermetallics** during aging formed at **solder/Ag** and **Cu** substrate in Pb-free **solders**, Sn-3.5Ag and the effect of the Ni, Zn addn. to prevent the growth. After aging, Ag<sub>3</sub>Sn and CuSn **intermetallics** thicknesses were very thin in the Sn-3.5Ag compared with Sn-40Pb. Both the case of **Ag** and **Cu** substrate, added Zn in the **solder** concd. at **Ag/Ag<sub>3</sub>Sn**, **Cu/Cu<sub>3</sub>Sn** interface during aging, resp. After 150.degree.C for 960 h, addn. of Zn to Sn-3.5Ag suppressed the growth of Ag<sub>3</sub>Sn and CuSn **intermetallics**. On the other hand, added Ni in the **solder** concd. only in **Cu** substrate. Ni concd. layer was formed at the Cu<sub>6</sub>Sn<sub>5</sub>/**solder** interface without aging. The d. of metal additives such as Ni or Zn suppressed the growth of **intermetallics** at the **solder**/substrate interface regardless of position of concd. layer.

AN 130:69829 HCA  
TI Comparison of mechanical fatigue fracture behavior of eutectic Sn-Ag  
**solder** with and without Cu6Sn5 **intermetallic** particulate  
reinforcement  
AU Gibson, A. W.; Subramanian, K. N.; **Bieler, T. R.**  
CS Materials Science and Mechanics, Michigan State University, MI, USA  
SO J. Adv. Mater. (1998), 30(2), 19-24  
CODEN: JADMEK; ISSN: 1070-9789  
PB Society for the Advancement of Material and Process Engineering  
DT Journal  
LA English  
AB The isothermal mech. fatigue fracture behavior of noncomposite eutectic  
Sn-Ag and composite eutectic Sn-Ag **solder** contg. 20 vol.% Cu6Sn5  
is examd. Single shear lap joints of both **solders** were  
fabricated using copper substrates and subjected to isothermal mech.,  
cantilever bending fatigue at a frequency of 50 Hz. The fracture  
surfaces  
of noncomposite eutectic Sn-Ag **solder** joints exhibited ductile,  
mixed mode (I and II) fracture behavior and step-type fatigue striations  
that originated at a local region. The fracture surfaces of the  
composite  
eutectic Sn-Ag **solder** contg. 20 vol.% Cu6Sn5 exhibited cleavage  
of the Cu6Sn5 particulate reinforcement and ductile, Mode I fracture of  
the eutectic matrix with no single origin of initiation corresponding to  
homogeneous ductile fracture.

Examiner's *GR*

AN 127:84578 HCA  
TI Issues regarding microstructural coarsening due to aging of eutectic **tin-silver solder**  
AU Gibson, A.W.; Choi, S.L.; Subramanian, K.N.; Bieler, T.R.  
CS Department of Materials Science and Mechanics, Michigan State University, East Lansing, MI, 48824-1226, USA  
SO Des. Reliab. Solders Solder Interconnect., Proc. Symp. (1997), 97-103.  
Editor(s): Mahidhara, Rao K. Publisher: Minerals, Metals & Materials Society, Warrendale, Pa.  
CODEN: 64QHAZ  
DT Conference  
LA English  
AB Pending Federal regulations, environmental concerns, and alternate m.p.. **solders** provide the impetus for using Pb-free **solders**. Automotive electronics and **solders** are exposed to extreme thermal cycling at -40-+150.degree. under cyclic and quasi-static conditions [1]. and they experience low and high frequency mech. fatigue vibrations. Since coarsening of microstructural features is known to affect fatigue resistance, the aging behavior is studied using eutectic **Sn-Ag solder** as a model system, with and without 20 V% of a Cu6Sn5 **intermetallic composite** strengthening phase. The **composite solder** was developed to det. whether the microstructure could be stabilized to prevent coarsening.  
For comparative purposes, a **composite solder** was also made using eutectic **Sn-Pb** as the matrix. Small single shear lap specimens with a size similar to joints in microelectronic applications are used to obtain microstructures that result in real **solder** joints. Eutectic **Sn-Ag solder** joint microstructures coarsen when aged at +60-+150.degree. for as little as 100 h. The microstructural evolution is monitored with aging temp. and time, and the kinetics of aging is detd. The effects of adding **composite intermetallic** phases on the aging behavior are compared to the model **Sn-Ag** system. The effect of cyclic aging vs. static aging is studied in the **Sn-Ag/Cu6Sn5** and **Sn-Pb/Cu6Sn5 composite solders**.

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 Single shear lap joints of both solders were fabricated using copper substrates and subjected to isothermal mech., cantilever bending fatigue at a frequency of 50 Hz. The fracture surfaces of noncomposite eutectic Sn-Ag solder joints exhibited ductile, mixed mode (I and II) fracture behavior and step-type fatigue striations that originated at a local region. The fracture surfaces of the composite eutectic Sn-Ag solder contg. 20 vol.% Cu6Sn5 exhibited cleavage of the Cu6Sn5 particulate reinforcement and ductile, Mode I fracture of the eutectic matrix with no single origin of initiation corresponding to homogeneous ductile fracture.  
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 (1) Choi, S; Design & Reliability of Solders and Solder Interconnects 1997, P241  
 (2) Gibson, A; Design & Reliability of Solders and Solder Interconnections 1997, P97 HCA  
 (3) Gibson, A; IEEE International Symposium on Electronics & the Environment 1997, P246  
 (5) Mahidhara, R; Design & Reliability of Solders and Solder Interconnections 1997, P75 HCA  
 (6) McCormack, M; IEEE Transactions on Components Packaging and Manufacturing Technology-Part A 1994, V17(3), P452 HCA  
 ALL CITATIONS AVAILABLE IN THE RE FORMAT

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AN 127:84587 HCA  
TI Mechanical properties of Sn-Ag **composite solder** joints  
containing copper-based **intermetallics**  
AU Choi, S.L.; Gibson, A. W.; Mcdougall, J.L.; Bieler, T.R.; Subramanian,  
K.N.  
CS Department of Materials Science and Mechanics, Michigan State University,  
East Lansing, MI, 48824-1226, USA  
SO Des. Reliab. Solders Solder Interconnect., Proc. Symp. (1997), 241-245.  
Editor(s): Mahidhara, Rao K. Publisher: Minerals, Metals & Materials  
Society, Warrendale, Pa.  
CODEN: 64QHAZ  
DT Conference  
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AB Differential thermal expansion in electronic systems induce stresses  
resulting in substantial cyclic deformation of solder joints, which leads  
to eventual fracture. While fatigue deformation is a major concern for  
electronic solders, creep constitutes an important component of  
deformation since stress relaxation occurs after a temp. change. In  
realistic thermal cycles there is sufficient time for stress relaxation  
processes to occur, and creep induced damage may result. Small single  
shear lap joint specimens were made to simulate realistic solder joints.  
By aging these specimens at different temps., several variations in  
microstructure were obtained. In an effort to modify creep strength of a  
model Sn-Ag lead-free solder, copper based **intermetallics** were  
introduced into the solder. Solder joints were deformed in creep  
conditions at room temp., and after some steady state creep strain, load  
changes were made to facilitate the evaluation of the stress dependence  
of strain-rate and to reduce the no. of test specimens. Comparisons between  
unaged and aged specimens, and between non-composite and **composite  
solders**, were performed. The anal. of fracture surface of crept  
solder joints was performed with SEM.